

<b>Notice of References Cited</b>	Application/Control No. 10/518,503		Applicant(s)/Patent Under Reexamination EGGENWEILER ET AL.	
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Bernes, J. Allergy Clin. Immunol, Jul. 2000, pgs. 5-16
	V	Kobayashi, et al., Mediators of Inflammation, Vol. 2007, Article ID 58901, 9 pgs.
	W	Reffellmann, et al., Circulation 2003;108;239-244
	X	Rybalkin, et al., Circ. Res. 2002;90;151-157

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